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Power MOSFET

30 V, 75 A, Single N-Channel, SO-8FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Low RG
- These are Pb-Free Devices

Applications

- Refer to Application Note AND8195/D
- CPU Power Delivery
- DC-DC Converters and Low Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Pai	Parameter				Unit
Drain-to-Source Vo	ltage		V_{DSS}	30	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain Current R _{0JA} (Note 1)		T _A = 25°C T _A = 85°C	I _D	16 11.5	Α
Power Dissipation R _{θJA} (Note 1)		T _A = 25°C T _A = 85°C	P_{D}	2.2 1.15	W
Continuous Drain Current R _{θJA} ≤10 s		T _A = 25°C T _A = 85°C	I _D	26 18.8	Α
Power Dissipation $R_{\theta JA} \leq 10 \text{ s}$	Steady	T _A = 25°C T _A = 85°C	P_{D}	5.8 3	W
Continuous Drain Current R _{0JA} (Note 2)	State	T _A = 25°C T _A = 85°C	I _D	10.2 7.3	А
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C T _A = 85°C	P _D	0.88 0.46	W
Continuous Drain Current R ₀ JC (Note 1)		T _C = 25°C T _C = 85°C	I _D	75 54	Α
Power Dissipation R _{θJC} (Note 1)		T _C = 25°C T _C = 85°C	P _D	48 25	W
Pulsed Drain Current	t _p =10 μs	T _A = 25°C	I _{DM}	225	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to +150	°C
Source Current (Body Diode)			I _S	40	Α
Drain to Source dV/dt			dV/dt	6	V/ns
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 30 V, V_{GS} = 10 V, I_{L} = 31 A, L = 0.3 mH, R_{G} = 25 Ω)			EAS	144	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

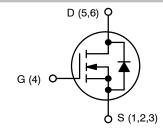
- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.



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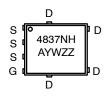
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V _{(BR)DSS}	(BR)DSS R _{DS(ON)} MAX	
2014	5.0 mΩ @ 10 V	
30 V	8.0 mΩ @ 4.5 V	75 A



N-CHANNEL MOSFET

SO-8 FLAT LEAD CASE 488AA STYLE 1



MARKING DIAGRAM

A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4837NHT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4837NHT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.6	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	56.6	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	142	C/VV
Junction–to–Ambient (t≤10 s)	$R_{ hetaJA}$	21.6	

ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise specified)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•					1	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				27.5		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	$T_{J} = 25 ^{\circ}\text{C}$ $T_{J} = 125 ^{\circ}\text{C}$			1 10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.5	2.1	2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.7		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = 10 \text{ V to}$	I _D = 30 A		3.7	5.0	
		11.5 V	I _D = 15 A		3.7		
		V _{GS} = 4.5 V	I _D = 30 A		6.5	8.0	mΩ
			I _D = 15 A		6.4		1
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 50 A			67		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				2234	3016	
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 12 V			450	608	pF
Reverse Transfer Capacitance	C _{RSS}				243	375	
Total Gate Charge	Q _{G(TOT)}				15.9	23.8	
Threshold Gate Charge	Q _{G(TH)}	V 45VV	IT \		2.8	4.3]
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$			6.4	9.5	nC
Gate-to-Drain Charge	Q_{GD}				6.6	9.8	
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 11.5 V, V _{DS} = 15 V; I _D = 15 A			34.4	53	nC
SWITCHING CHARACTERISTICS (Note 6)							
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}, I_{D} = 15 \text{ A},$ $R_{G} = 3.0 \Omega$			15.2	22.8	
Rise Time	t _r				27.5	41.3	
Turn-Off Delay Time	t _{d(OFF)}				18.3	27.5	ns
Fall Time	t _f				7.1	10.6	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

^{5.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 6)				•	•	
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 11.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			9.0	14	
Rise Time	t _r				19.6	29.3	
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 15 A, R_G$	= 3.0 Ω		28	38.7	ns
Fall Time	t _f	1			4.7	7	
DRAIN-SOURCE DIODE CHARACTI	ERISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 30 A T _J = 25°	T _J = 25°C		0.83	1.2	V
		I _S = 30 A	T _J = 125°C		0.71		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0$ V, $dI_S/dt = 100$ A/ μ s, $I_S = 30$ A			23.5		
Charge Time	t _a				11.3		ns
Discharge Time	t _b				12.2		
Reverse Recovery Charge	Q _{RR}				8		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				0.93		nH
Drain Inductance	L _D	T _A = 25°C			0.005		
Gate Inductance	L _G				1.84		
Gate Resistance	R_{G}				0.9		Ω

^{5.} Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

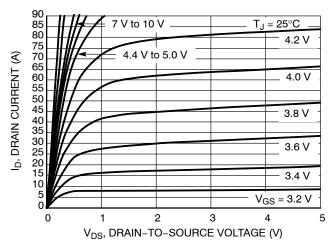


Figure 1. On-Region Characteristics

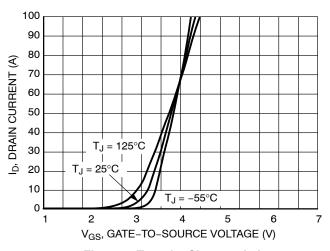


Figure 2. Transfer Characteristics

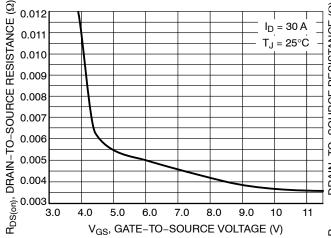


Figure 3. On–Resistance versus Gate–to–Source Voltage

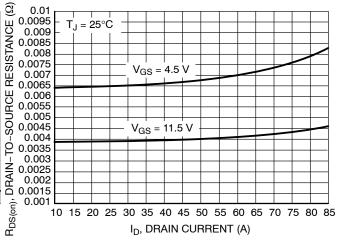


Figure 4. On-Resistance versus Drain Current and Gate Voltage

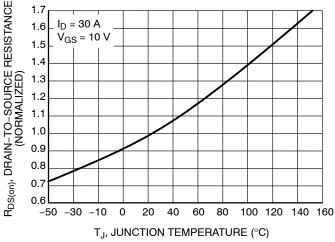


Figure 5. On–Resistance Variation with Temperature

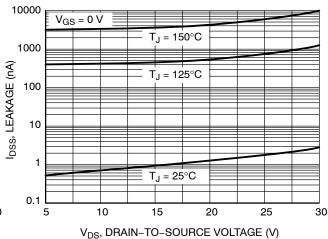
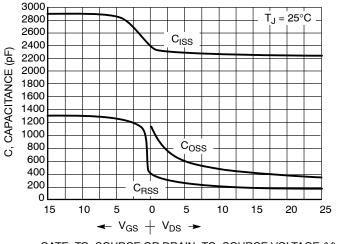


Figure 6. Drain-to-Source Leakage Current versus Voltage



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (V)

Figure 7. Capacitance Variation

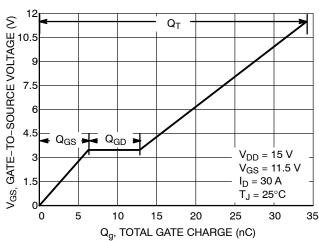


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Gate Charge

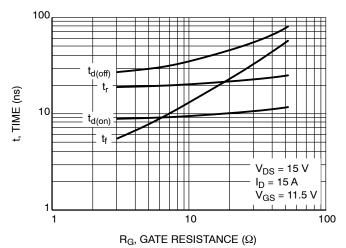


Figure 9. Resistive Switching Time Variation versus Gate Resistance

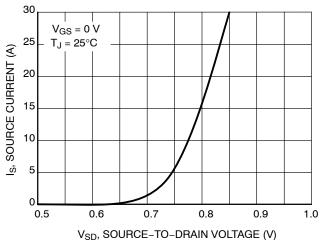


Figure 10. Diode Forward Voltage versus Current

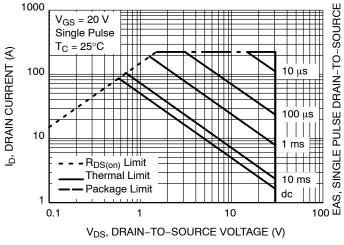


Figure 11. Maximum Rated Forward Biased Safe Operating Area

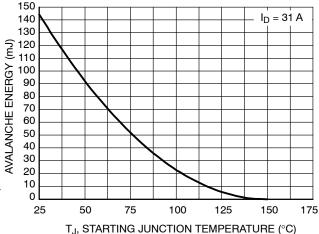


Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature

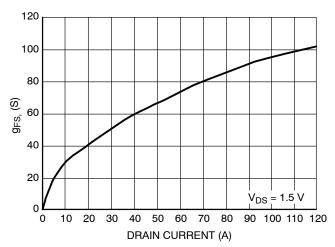
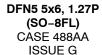
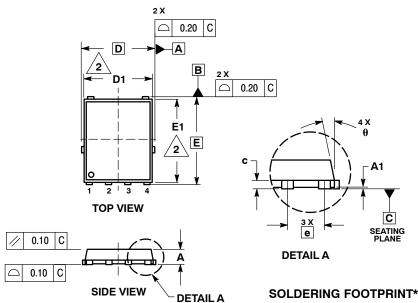


Figure 13. G_{FS} versus Drain Current

PACKAGE DIMENSIONS



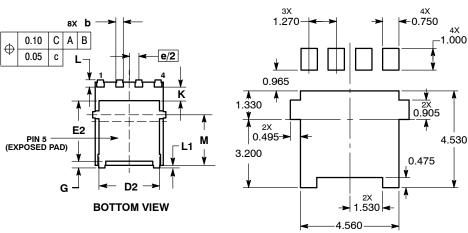


- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D		5.15 BSC	;		
D1	4.50	4.90	5.10		
D2	3.50		4.22		
E	6.15 BSC				
E1	5.50	5.80	6.10		
E2	3.45		4.30		
е	1.27 BSC				
G	0.51	0.61	0.71		
K	1.20	1.35	1.50		
L	0.51	0.61	0.71		
L1	0.05	0.17	0.20		
M	3.00	3.40	3.80		
θ	0 °		12 °		

- STYLE 1: PIN 1. SOURCE 2. SOURCE

 - SOURCE GATE
 - 5. DRAIN



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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